

17. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: ZNFTP450	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT	 LG	Approved by: Quality Manager
Filename: 1M1703010081-10.ZNF	Test Dates: 02/27/2017 - 03/11/2017	DUT Type: Portable Handset	Page 72 of 74	

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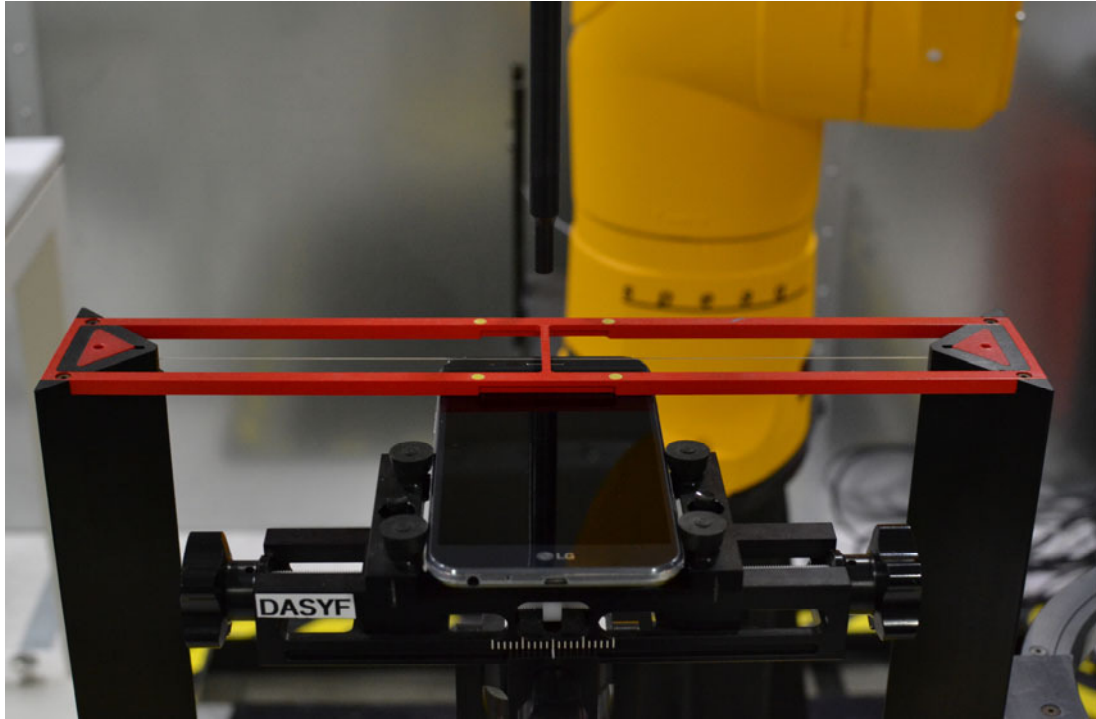


Figure 17-1
Ear Reference Point HAC Phantom Alignment

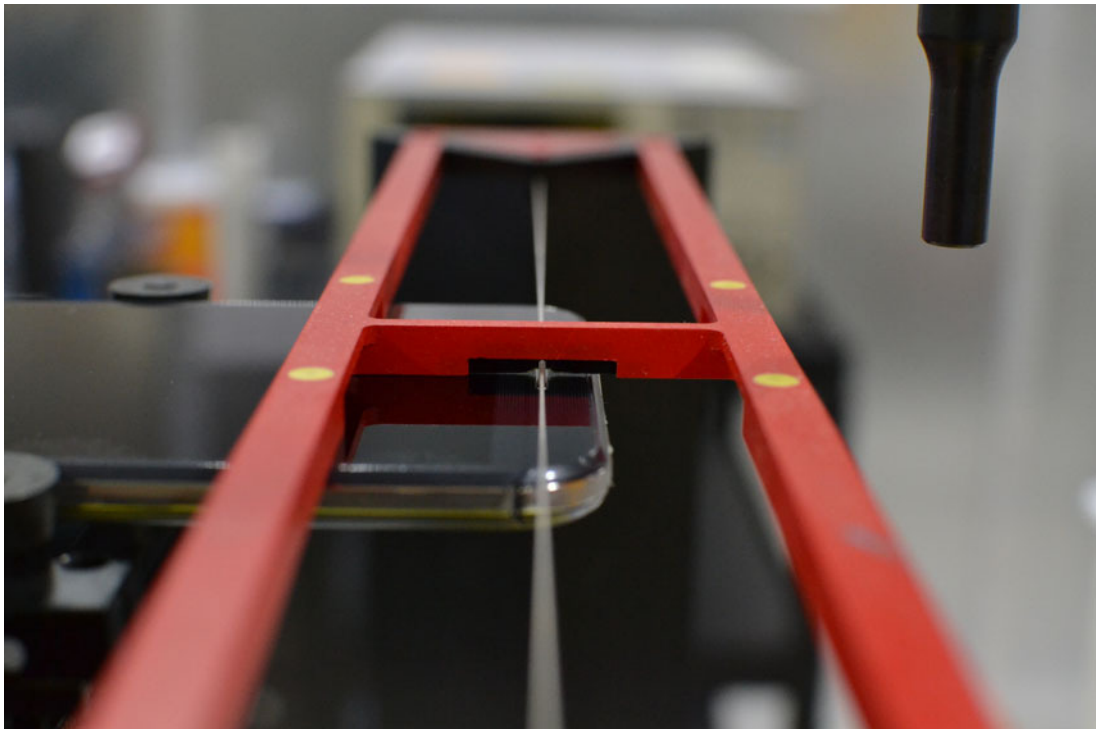


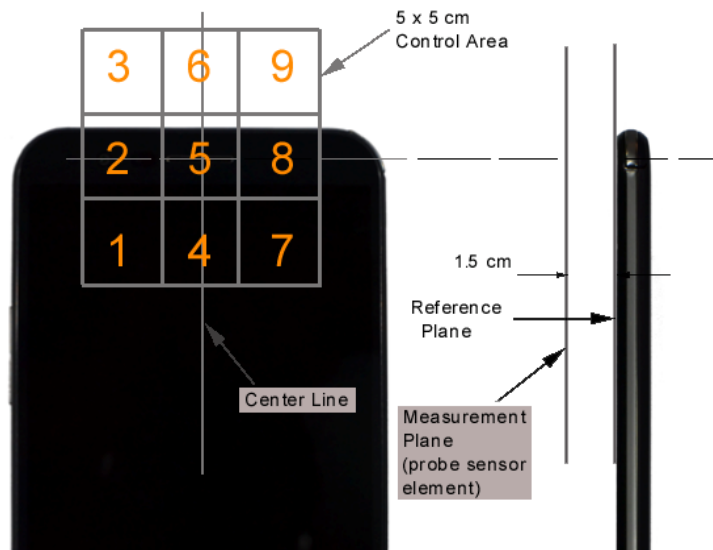
Figure 17-2
HAC Phantom Plane Alignment

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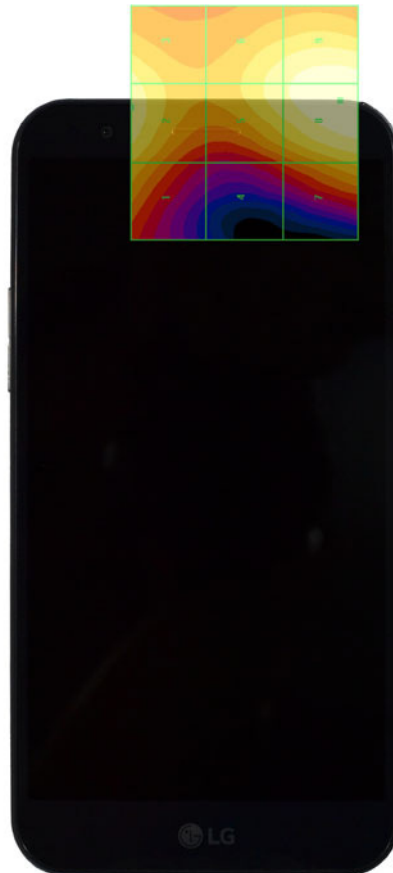
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**Figure 17-3 5x5 Scan grid above WD
(Acoustic Centered Scan area pictured)**



**Figure 17-4 E-Field WD Scan overlay
(T-coil Centered Scan area pictured)**

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